



International Journal of Electronics, Mechanical and Mechatronics Engineering: Ijemme (Paperback)

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Istanbul Aydin University International, United States, 2018. Paperback. Condition: New. Language: English. Brand new Book. It is our great pleasure to publish new issue of international journal, "International Journal of Electronics, Mechanical and Mechatronics Engineering" (IJEMME) of Istanbul Aydin University. Our sustainable strategy is to demonstrate new trends in science and technology subject to high quality standards by ensuring a stringent peer review process. The scope of the International Journal of Electronics, Mechanical and Mechatronics Engineering (IJEMME) covers the novel scientific papers about Electronics, Image Processing, Information Theory, Electrical Systems, Power Electronics, Control Theory, Embedded Systems, Robotics, Motion Control, Stochastic Modeling, System Design, Multidisciplinary Engineering, Computer Engineering, Optical Engineering, Design Optimization, Material Science, Metamaterials, Heat and Mass Transfer, Kinematics, Dynamics, Thermo-Dynamics, Energy and Applications, Renewable Energy, Environmental Impacts, Structural Analysis, Fluid Dynamics and related topics of the above subjects. Manuscripts reporting original theoretical and/or experimental work and tutorial expositions of permanent reference value are highly welcome. I sincerely wish to thank the editor in chief, members of the editorial board, and authors of the seventh issue who have generously contributed their time and knowledge to the work and the mission of the journal.



Reviews

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